

CRYLINK
LINKING VALUE



Crylink Nd:YLF

For High Energy Lasers



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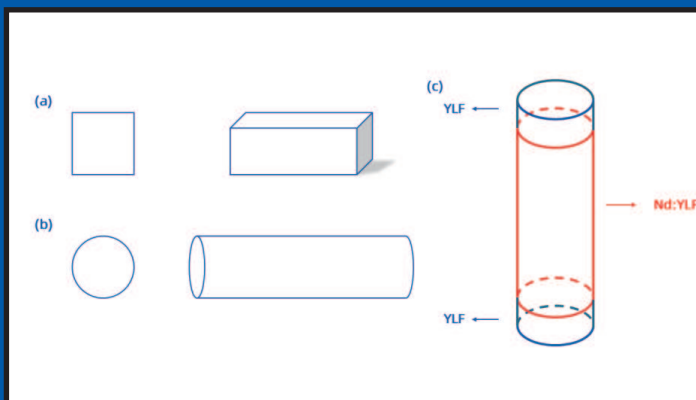
Crylink Nd:YLF • Superior Quality

Crylink, as one of the world's leading manufacturers of Nd:YLF crystals, leverages its independently developed advanced crystal growth technology to stably produce crystal blanks with doping concentrations ranging from 0.5% Nd at to 2.0% Nd at.

Nd:YLF crystals feature exceptionally broad fluorescence linewidths (485 μ s at 1% Nd doping concentration), long upper-level lifetimes, linearly polarized output, and natural birefringence significantly greater than stress-induced birefringence.



Crylink Nd:YLF • Product Type



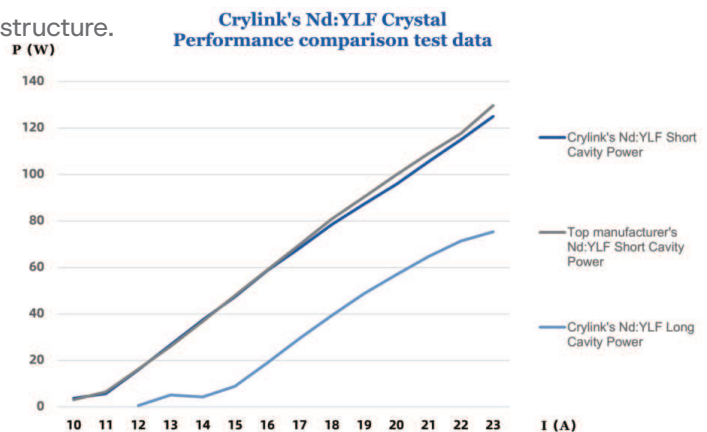
Crylink's standard Nd:YLF crystal products are designed as dual-pass coated rods. Users can integrate these crystal rods with upstream LD pump modules or side-pumping systems to achieve high-energy pulse laser outputs ranging from hundreds of millijoules to joules.

Additionally, we offer customized crystal solutions tailored to specific user requirements, such as block-shaped crystals and bonded structures like YLF + Nd:YLF + YLF, ensuring optimal performance and application outcomes.

Crylink Nd:YLF • Product Performance

Crylink's Nd:YLF crystals are renowned for their exceptionally broad fluorescence linewidth and low thermal lensing effect, making them ideal for high-power, high-energy laser systems. These advantages enhance the lasers' performance and help optimize their internal structure.

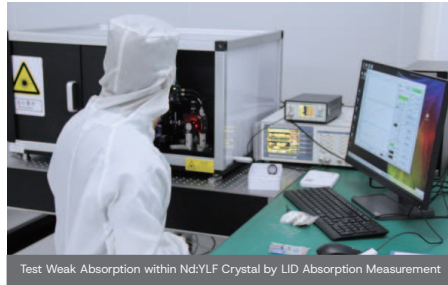
Specifically, laser systems based on Nd:YLF crystals typically require only a single-stage amplification to achieve performance on par with or surpass the effects of three to four-stage laser amplification systems based on Nd:YAG crystals. The following chart compares the performance of Crylink's Nd:YLF crystals with that of the top global crystal manufacturers.



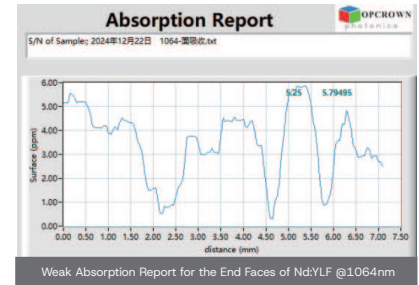
Crylink Nd:YLF · Test on Inner Quality

Crylink has established a dedicated laser testing platform to evaluate the internal quality of Nd:YLF crystals. The Agilent spectrophotometer is used to measure their absorption and transmittance, to determine crystal's doping concentration and the consistency of the concentration gradient.

Additionally, the laser-induced weak absorption meter (LID) is employed to test the weak absorption coefficient of the crystal's interior using efficient and precise laser irradiation techniques. This ensures that every crystal meets high standards of internal quality.



Test Weak Absorption within Nd:YLF Crystal by LID Absorption Measurement



Crylink Nd:YLF · Test on Production Process

Crylink adheres to the ISO production system, implementing strict standards at every stage of the manufacturing process. We utilize an interferometer to precisely measure the surface roughness of Nd:YLF crystals with nanometer-level, non-contact accuracy, after each phase of processing.

Additionally, a Zygo interferometer is employed to assess the flatness and wavefront distortion of the crystals, enabling precise quantification of minute surface defects and irregularities.



ZYGO Interferometer

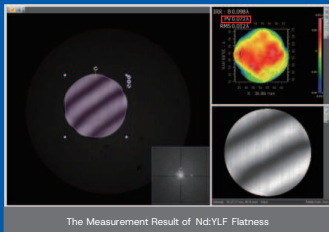


Nd:YLF Finished Product

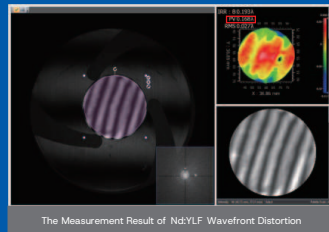
*Crylink's Nd:YLF crystal processing capability is shown in the ZYGO assay data (PV value):

Flatness $\lambda/12@633nm$

Wavefront distortion $\lambda/6@633nm$



The Measurement Result of Nd:YLF Flatness

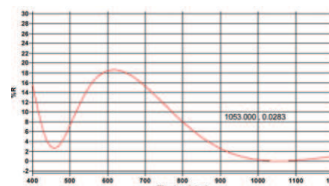


The Measurement Result of Nd:YLF Wavefront Distortion

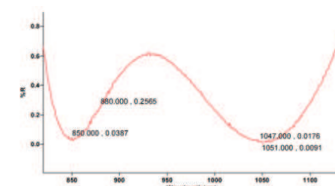
Crylink Nd:YLF · Test on Coating

Crylink conducts rigorous final product testing on Nd:YLF crystals. We use a surface profilometer to precisely measure the thickness and uniformity of the crystal's thin film. By creating steps and scanning surface height variations, we ensure the film meets the designed specifications.

An Agilent spectrophotometer is employed to measure the transmittance and reflectance of the crystals. Additionally, some samples were sent to third-party testing organizations, such as LIDARIS, Spica, and SIOM, for damage threshold testing. This ensures the reliability and performance of the Nd:YLF crystal's coated surfaces.



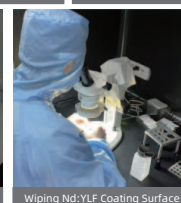
Transmittance of Nd:YLF Coating@1053nm



Transmittance of Nd:YLF Coating @1047nm



Agilent Spectrophotometer



Wiping Nd:YLF Coating Surface

*Crylink's transmittance of the coated surface of Nd:YLF crystals is shown in the spectrophotometer testing data below:

$R < 0.1\% @ 1053nm \& 1047nm$



Crylink Nd:YLF · Properties Index

Physical and Chemical Properties of Nd:YLF		Optical Properties of Nd:YLF	
Properties	Value	Absorption Peak Wavelength	792nm
Chemical Formula	Nd:LiYF ₄ (Nd:YLF)	Peak absorption coefficient (1.2%Nd at)	$\alpha=10.8 \text{ cm}^{-1}(\parallel c)$ @972nm $\alpha=3.59 \text{ cm}^{-1}(\perp c)$ @972nm
Crystal Structure	Tetragonal	Emission Peak Wavelength	1047nm(π polarization) 1053nm(σ polarization)
Thermal Conductivity	$6.3 \text{ Wm}^{-1}\text{K}^{-1}$	Emission Cross Section	$15 \times 10^{-20} \text{ cm}^2(\parallel c)$ @1047nm $10 \times 10^{-20} \text{ cm}^2(\perp c)$ @1053nm
Thermal Expansion Coefficient	$13.3 \times 10^{-6}/\text{K}(\perp c)$ $8.3 \times 10^{-6}/\text{K}(\parallel c)$	Fluorescence Lifetime (1%Nd at)	485 μs
Melting Point	819°C	Scatter Losses (1%Nd at)	< 0.2% /cm
Mohs Hardness	5Mohs		
Doping Concentration	0.5%Nd~2%Nd		

Crylink Nd:YLF · Standard Product

Crystal Type	Concentration	Diameter(mm)	Length(mm)	Coating	Damage Threshold
Nd:YLF	0.6%Nd at	3	95	AR/AR@ 1053nm	> 10J/cm ² @1064nm,10ns,10hz
		4	95		
		5	105		
	0.8%Nd at	3	120		
		4	120		
		5	120		
		4	150		
		5	150		

*The above is part of the standard product information, please contact sales for details:(+86 021-66566068/sales@crylink.com)



Note: All information and specifications in this product manual are subject to change at any time without notice. We reserve the right to make improvements and changes to our products and services. All test data is for reference only and actual performance may vary depending on specific applications and conditions of use.

Follow us on social media to get more information about Nd:YLF Crystal

